

SEARCHED

Class	Sub.	Date	Exmr.
375	130	1/12/03	eh
	142		
	343		
	371		
	145		
370	342	1/12/03	ej
	509		
update Search		6/22/04	eh
update Search		8/5/05	eh
update Search		4/19/06	eh
375	132		
	149		
	152		
	367		
	134		
	137		
	140		
	142		
	143		
	148		
	152		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	Date	Exmr.
EAST	1/12/03	eh
IEEEExplore	=	eh
update Search	6/22/04	eh
update Search	8/5/05	eh
update Search		
EAST	4/19/06	eh

INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.
375	130, 132	4/19/06	eh
	142, 149		
	145, 152		
	134, 137		
	140, 142		
	143, 148		
	v 152		
	343, 371		
	367		

(RIGHT OUTSIDE)

Search Notes (continued)



Application/Control No.

09/595,561

Examiner

Edith M. Chang

**Applicant(s)/Patent under
Reexamination**

DABAK ET AL.

Art Unit

2611

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
380	9,34 48,59	4/19/06	ek